

HORIBA Instruments Particle Analysis Jeffrey Bodycomb, Ph.D.

The Basics of Laser Diffraction

November 29, 2018

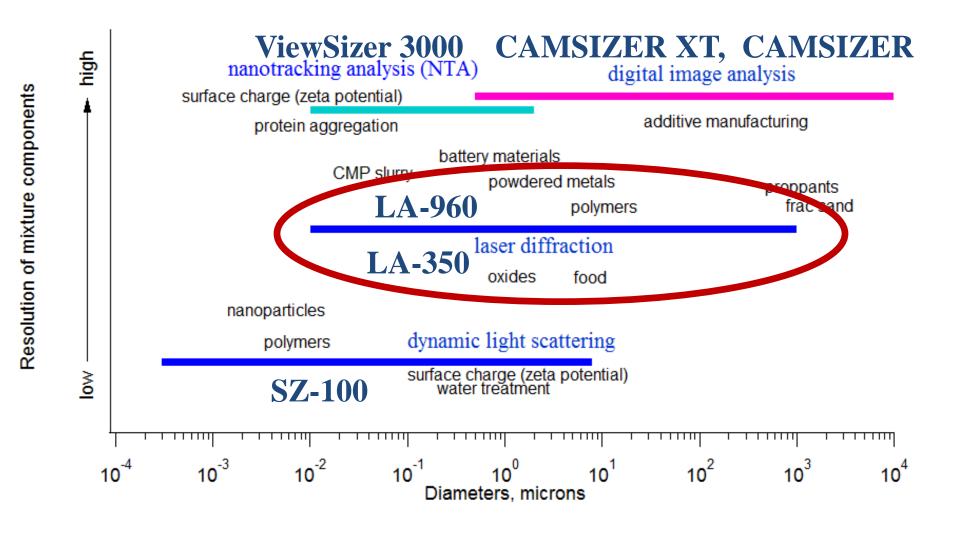
HORIBA

© 2018 HORIBA, Ltd. All rights reserved. Explore the future

Automotive Test Systems | Process & Environmental | Medical | Semiconductor | Scientific



Perspective



© 2018 HORIBA, Ltd. All rights reserved.

HORIBA



Why Particle Size?

Size affects material behavior and processing across a number of industries.

Industry	Industry	
Ceramic	Construction	
Oil/rubber	Chemical	
Battery	 Pharmaceutical	
Electricity	Food/Drink	
Automobile	Paper/Pulp	
Mining	Ink/Toner	

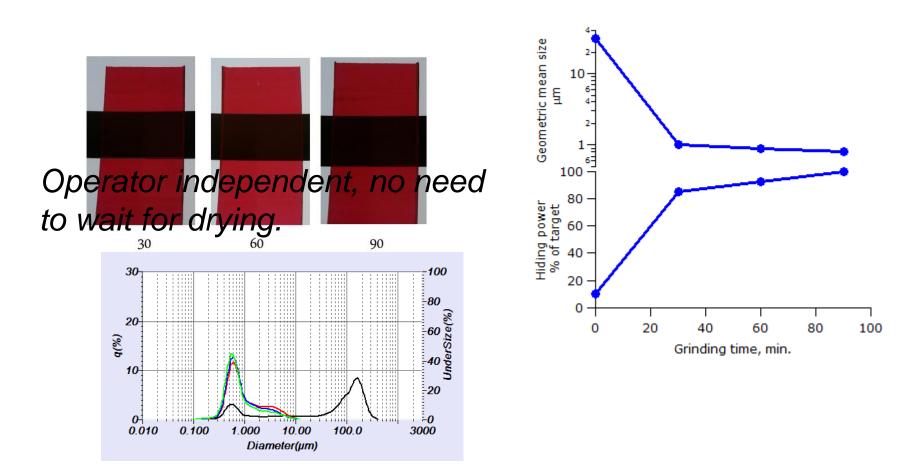
© 2018 HORIBA, Ltd. All rights reserved.

Explore the future



Application: Pigment Hiding Power

Operator dependent, need to wait for drying.



© 2018 HORIBA, Ltd. All rights reserved.

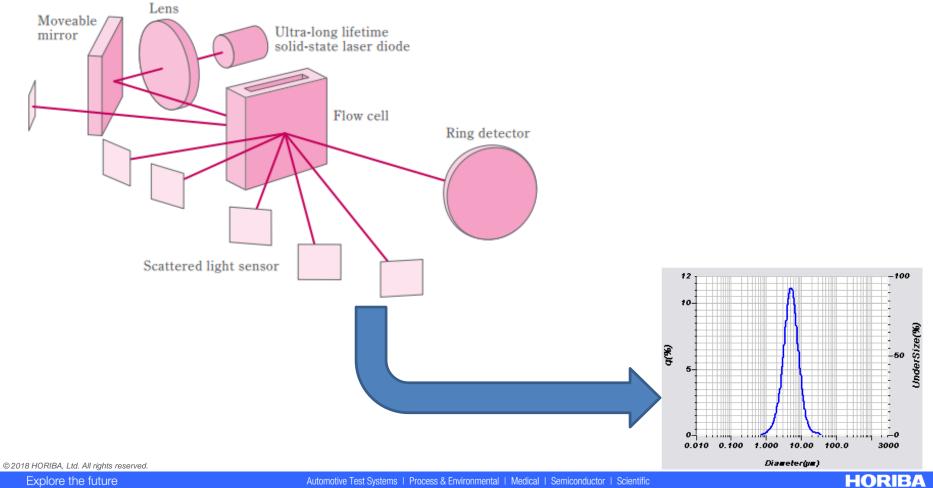




5

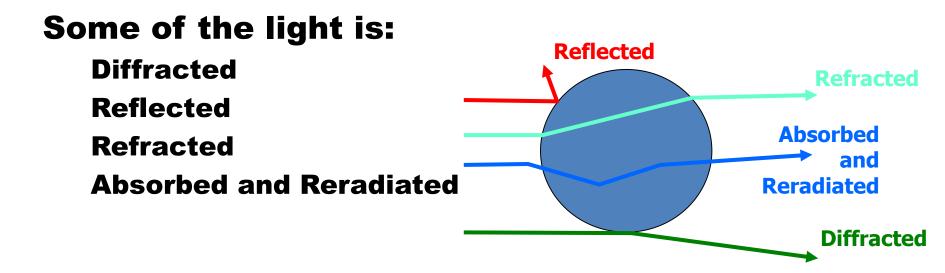
Core Principle

Investigate a particle with light and determine its size





When a Light beam Strikes a Particle



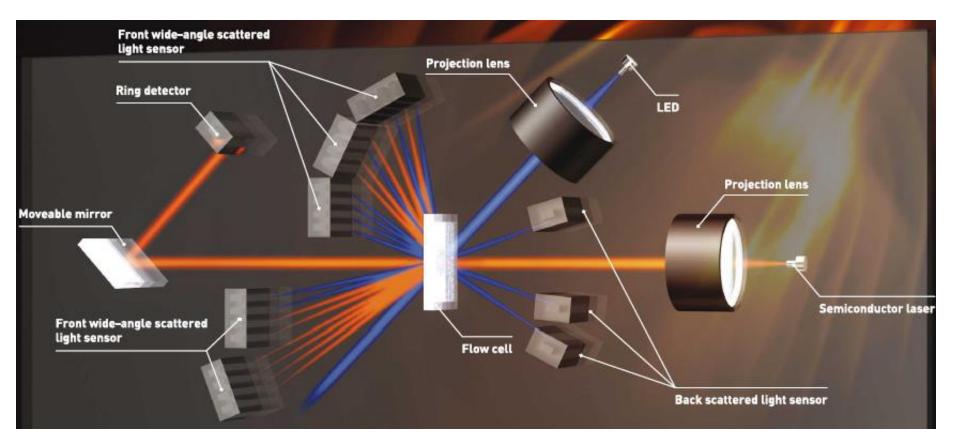
- Small particles require knowledge of optical properties:
 - Real Refractive Index (bending of light, wavelength of light in particle)
 - Imaginary Refractive Index (absorption of light within particle)
 - Refractive index values less significant for large particles
- Light must be collected over large range of angles

© 2018 HORIBA, Ltd. All rights reserved.

Explore the future



LA-960 Optics



© 2018 HORIBA, Ltd. All rights reserved.

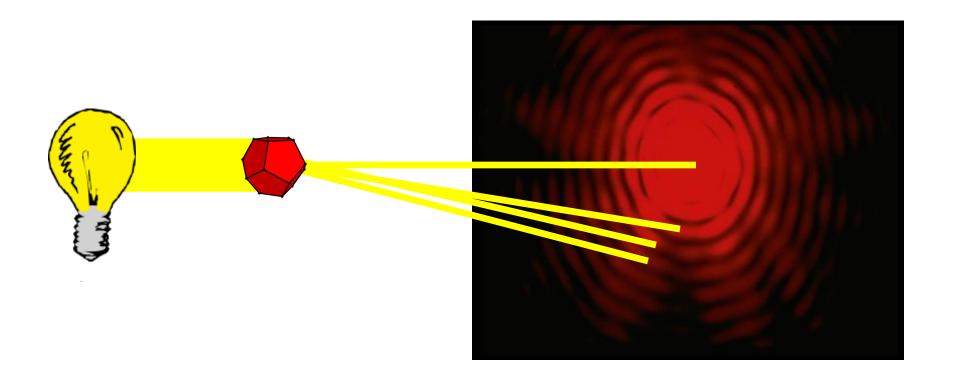
Explore the future

Automotive Test Systems | Process & Environmental | Medical | Semiconductor | Scientific

HORIBA



Diffraction Pattern



© 2018 HORIBA, Ltd. All rights reserved.

Explore the future

Automotive Test Systems | Process & Environmental | Medical | Semiconductor | Scientific





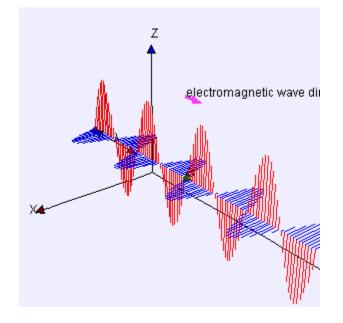
Light

Expressed in just in y-direction

$$E = E_0 \sin(ky - \omega t)$$

$$H = H_0 \sin(ky - \omega t)$$

Oscillating electric field Oscillating magnetic field (orthogonal to electric field)



Complements of Lookang @ weelookang.blogspot.com

© 2018 HORIBA, Ltd. All rights reserved.



Light: Interference

Look at just the electric field.

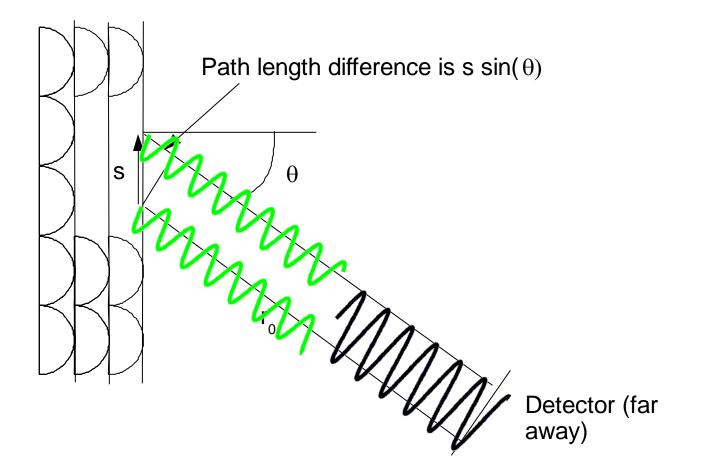
 $E = E_0 \sin(kx - \omega t + \phi)$ Oscillating electric field

 $E = E_0 \sin(kx - \omega t)$ Second electric field with phase shift

© 2018 HORIBA, Ltd. All rights reserved.



Path Length Difference



© 2018 HORIBA, Ltd. All rights reserved.





Use models to interpret data

Scattering data typically cannot be inverted to find particle shape.

We use optical models to interpret data and understand our experiments.

© 2018 HORIBA, Ltd. All rights reserved.

Explore the future





Laser Diffraction Models

Large particles -> Fraunhofer More straightforward math Large, opaque particles as 2-D disks Use this to develop intuition

All particle sizes -> Mie Messy calculations All particle sizes as 3-D spheres

© 2018 HORIBA, Ltd. All rights reserved.



Fraunhofer Approximation

$$(S_1)^2 = (S_2)^2 = \alpha^4 \left[\frac{J_1(\alpha \sin \Theta)}{\alpha \sin \Theta} \right]^2$$
$$I(\Theta) = \frac{I_0}{k^2 a^2} \alpha^4 \left[\frac{J_1(\alpha \sin \Theta)}{\alpha \sin \Theta} \right]^2$$

dimensionless size parameter $\alpha = \pi D \lambda$;

 J_1 is the Bessel function of the first kind of order unity.

Assumptions:

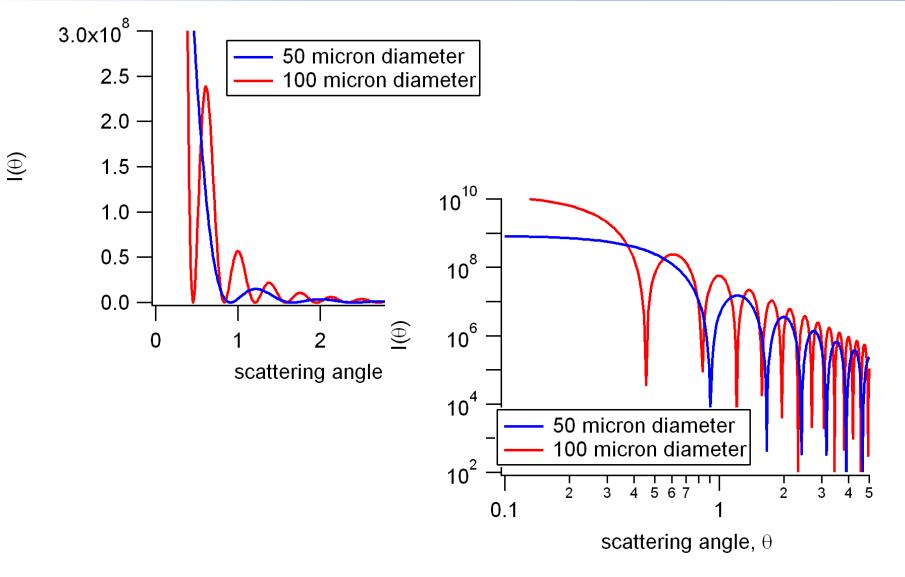
a) all particles are much larger than the light wavelength (only scattering at the contour of the particle is considered; this also means that the same scattering pattern is obtained as for thin two-dimensional circular disks)

b) only scattering in the near-forward direction is considered (Q is small).

Limitation: (diameter at least about 40 times the wavelength of the light, or $\alpha >>1$)* If λ =650nm (.65 µm), then 40 x .65 = 26 µm If the particle size is larger than about **26** µm, then the Fraunhofer approximation gives good results.

© 2018 HORIBA, Ltd. All rights reserved.

Fraunhofer: Effect of Particle Size



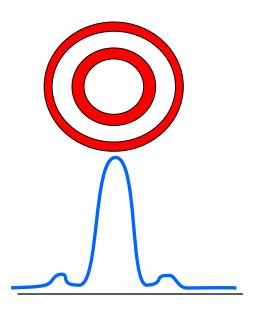
© 2018 HORIBA, Ltd. All rights reserved.



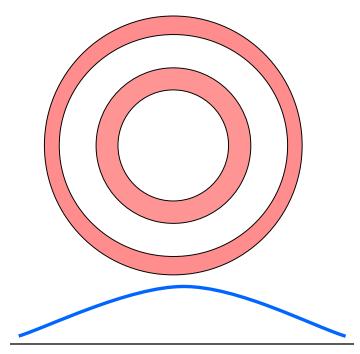
Diffraction: Large vs. Small

LARGE PARTICLE:

Peaks at low angles Strong signal



Narrow Pattern - High intensity



Wide Pattern - Low intensity

• SMALL PARTICLE:

- Peaks at larger angles
- Weak Signal

© 2018 HORIBA, Ltd. All rights reserved.

Explore the future

Automotive Test Systems | Process & Environmental | Medical | Semiconductor | Scientific



Poll

How many of you work with particles with sizes over 1 mm?

How many of you work with particles with sizes over 25 microns?

How many of you work with particles with sizes less than 1 micron?

Explore the future

17 HORIBA



Mie Scattering

$$I_{s}(m, x, \theta) = \frac{I_{0}}{2k^{2}r^{2}} \left(\left| S_{2} \right|^{2} + \left| S_{1} \right|^{2} \right)$$

Use computer for the calculations!

$$S_{1}(m, x, \theta) = \sum_{1}^{\infty} \frac{2n+1}{n(n+1)} \{a_{n}\pi_{n} + b_{n}\tau_{n}\}$$

$$S_{2}(m, x, \theta) = \sum_{1}^{\infty} \frac{2n+1}{n(n+1)} \{a_{n}\tau_{n} + b_{n}\pi_{n}\}$$

$$a_{n} = \underbrace{m \psi_{n}(mx)\psi_{n}'(x) - \psi_{n}(x)\psi_{n}'(nx)}_{m \psi_{n}(mx)\xi_{n}'(x) - \xi_{n}(x)\psi_{n}'(mx)}$$

$$b_{n} = \underbrace{\psi_{n}(mx)\psi_{n}'(x) - m \psi_{n}(x)\psi_{n}'(mx)}_{\psi_{n}(mx)\xi_{n}'(x) - m \xi_{n}(x)\psi_{n}'(mx)}$$

 $\tau_n = \frac{d}{d\theta} \left(P_n^1(\cos\theta) \right)$ $\xi, \psi: \text{ Ricatti-Bessel functions}$

 $\pi_n = \frac{P_n^1(\cos\theta)}{\sin\theta}$

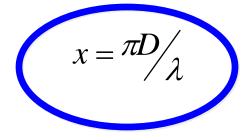
P_n¹:1st order Legendre Functions

© 2018 HORIBA, Ltd. All rights reserved.

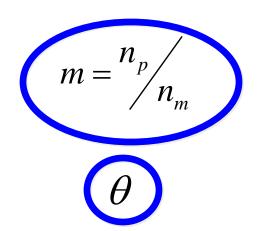


Critical Variables

The equations are messy, but require just three inputs which are shown below. The nature of the inputs is important.



Decreasing wavelength is the same as increasing size. So, if you want to measure small particles, decrease wavelength so they "appear" bigger. That is, <u>get a blue light</u> <u>source for small particles</u>.



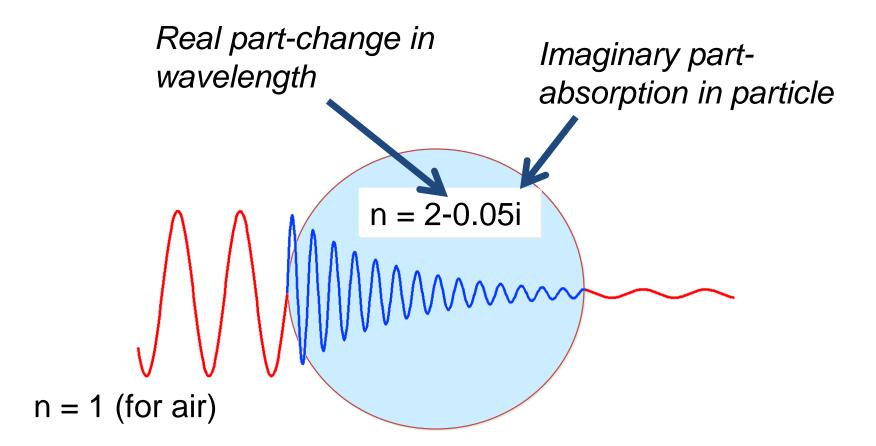
We need to know relative refractive index. As this goes to 1 there is no scattering.

Scattering Angle

© 2018 HORIBA, Ltd. All rights reserved.



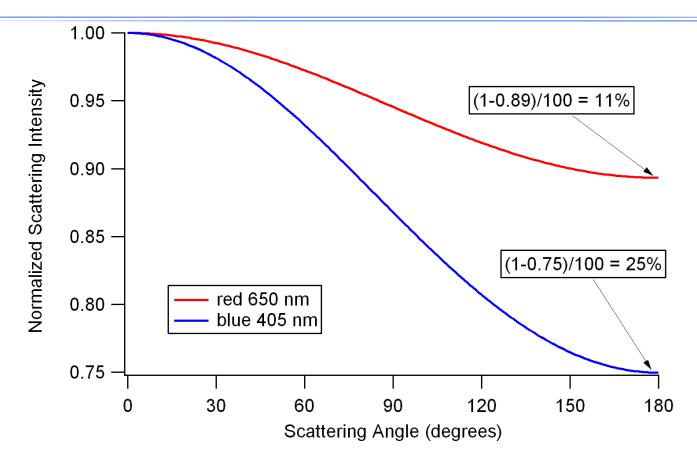
Refractive Index



© 2018 HORIBA, Ltd. All rights reserved.



Small Particles -> Blue light

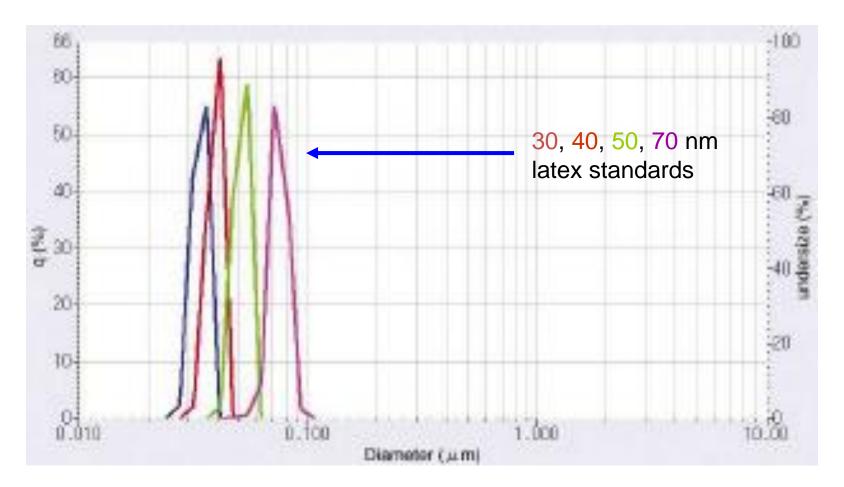


By using blue light source, we double the scattering effect of the particle. This leads to more sensitivity. This plot also tells you that you need to have the background stable to within 1% of the scattered signal to measure small particles accurately.

© 2018 HORIBA, Ltd. All rights reserved.



Example Results



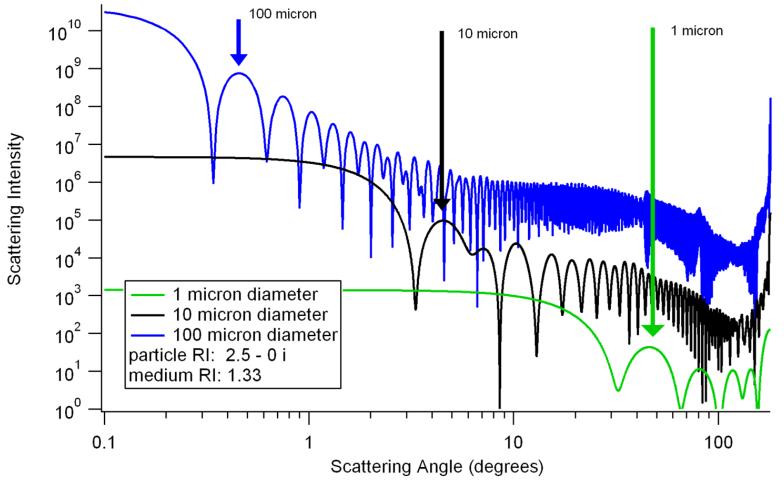
Data from very small particles.

© 2018 HORIBA, Ltd. All rights reserved.

Explore the future



Effect of Size



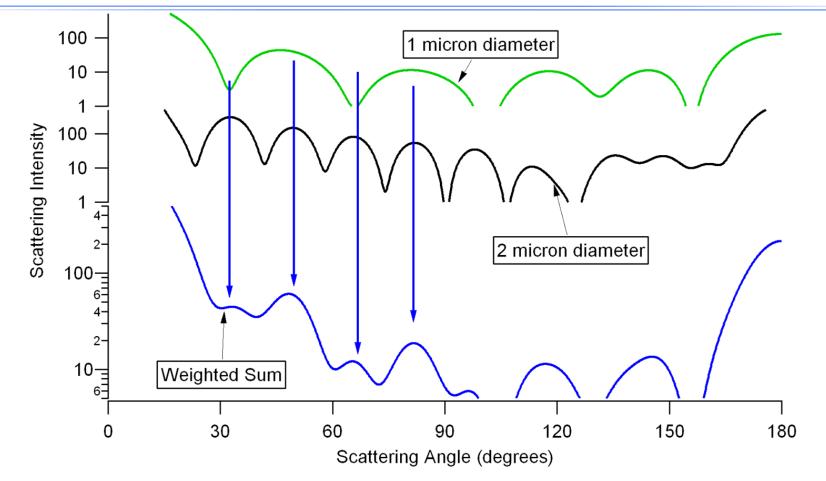
As diameter increases, intensity (per particle) increases and location of first peak shifts to smaller angle.

© 2018 HORIBA, Ltd. All rights reserved

Explore the future



Mixing Particles? Just Add

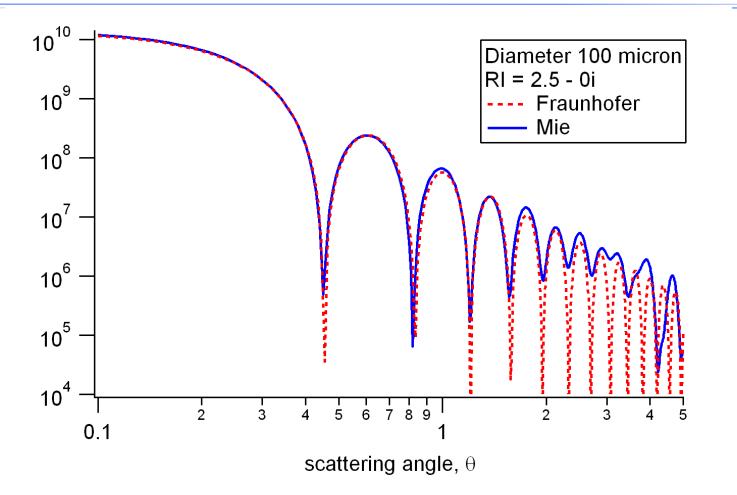


The result is the weighted sum of the scattering from each particle. Note how the first peak from the 2 micron particle is suppressed since it matches the valley in the 1 micron particle.

© 2018 HORIBA, Ltd. All rights reserved.



Comparison, Large Particles



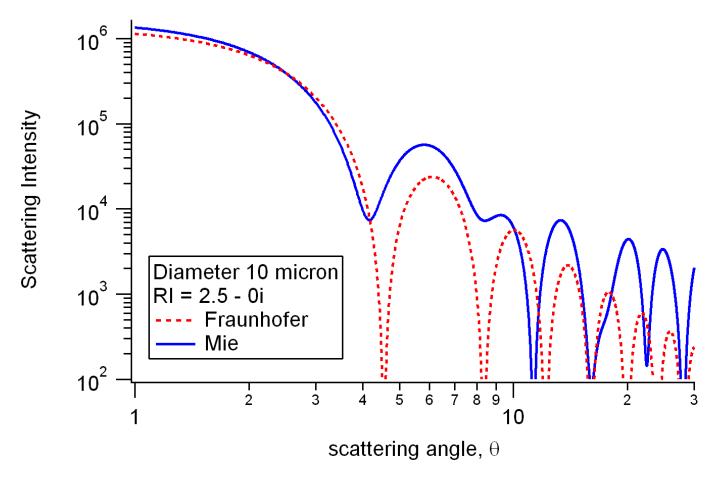
For large particles, match is good out to through several peaks.

© 2018 HORIBA, Ltd. All rights reserved.

Explore the future



Comparison, Small Particles



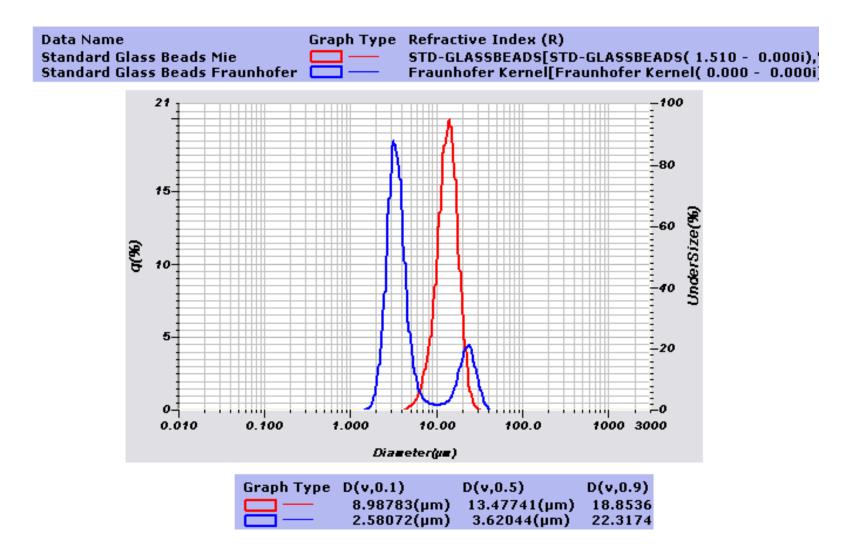
For small particles, match is poor. Use Mie.

© 2018 HORIBA, Ltd. All rights reserved.

Explore the future



Glass Beads and Models



© 2018 HORIBA, Ltd. All rights reserved.

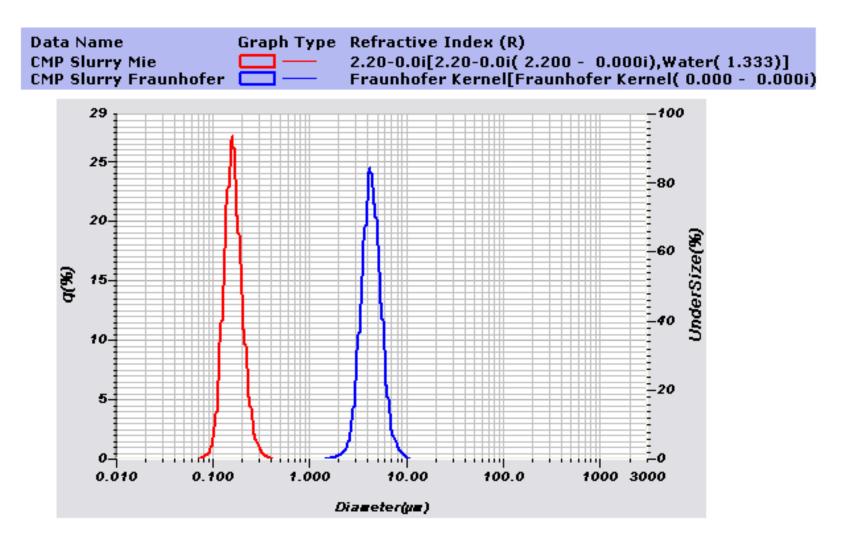
Explore the future

27

HORIBA



CMP Slurry

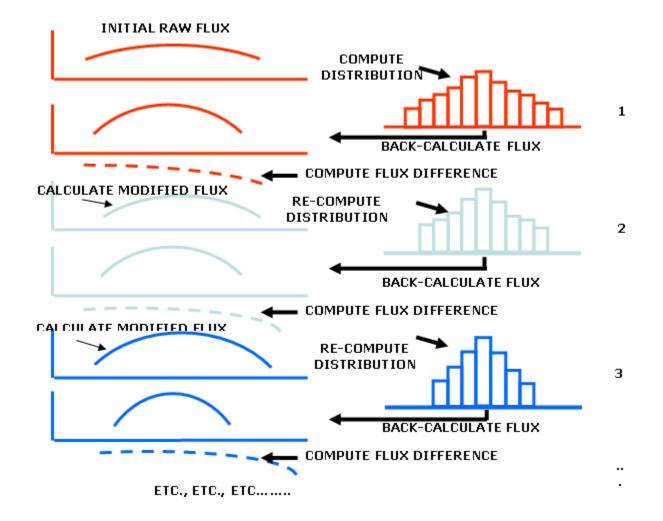


© 2018 HORIBA, Ltd. All rights reserved.

Explore the future



Analyzing Data: Convergence



© 2018 HORIBA, Ltd. All rights reserved.



Other factors

Size, Shape, and Optical Properties also affect the angle and intensity of scattered light

Extremely difficult to extract shape information without *a priori* knowledge

Assume spherical model

© 2018 HORIBA, Ltd. All rights reserved.





Pop Quiz

What particle shape is used for laser diffraction calculations?

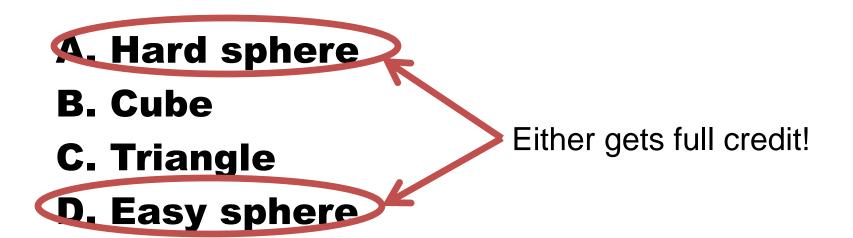
- A. Hard sphere
- **B.** Cube
- **C. Triangle**
- **D. Easy sphere**

© 2018 HORIBA, Ltd. All rights reserved.



Pop Quiz

What particle shape is used for laser diffraction calculations?



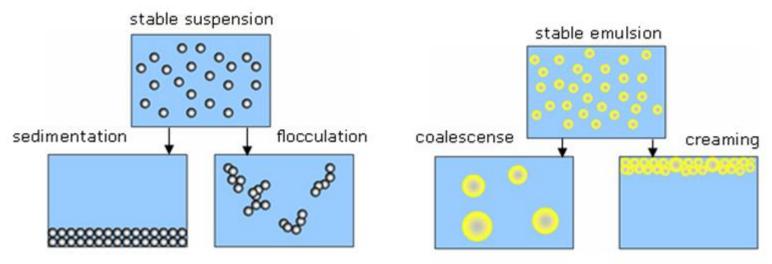
© 2018 HORIBA, Ltd. All rights reserved.





Measurement Workflow

Prepare the sample Good sampling and dispersion a must! May need to use surfactant or admixture

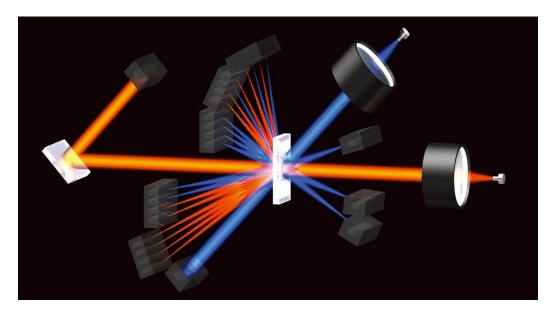


© 2018 HORIBA, Ltd. All rights reserved.



Measurement Workflow

Prepare the system Align laser to maximize signal-to-noise Acquire blank/background to reduce noise



© 2018 HORIBA, Ltd. All rights reserved.

Explore the future



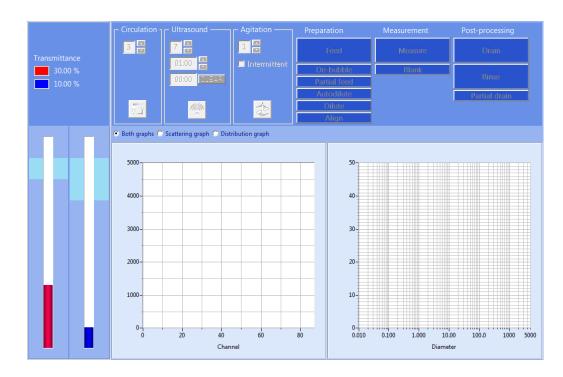


Measurement Workflow

Introduce sample

Add sample to specific concentration range Pump sample through measurement zone

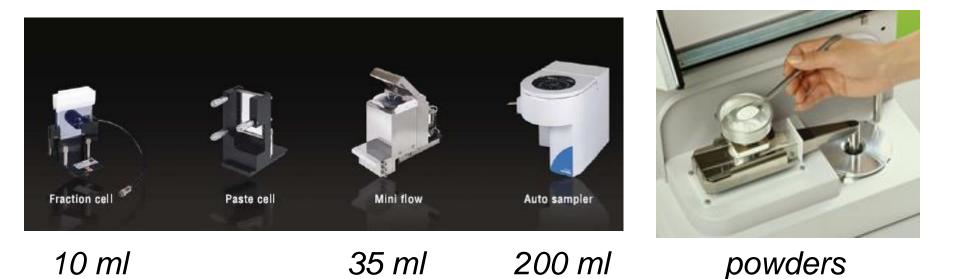
Final dispersion (ultrasonic)



© 2018 HORIBA, Ltd. All rights reserved.



Flexible Sample Handlers



Wide range of sample cells depending on application
High sensitivity keeps sample requirements at minimum
Technology has advanced to remove trade-offs

© 2018 HORIBA, Ltd. All rights reserved.





How much sample (wet)?

It depends on sample, but here are some examples. **Larger, broad distributions require larger sample volume**

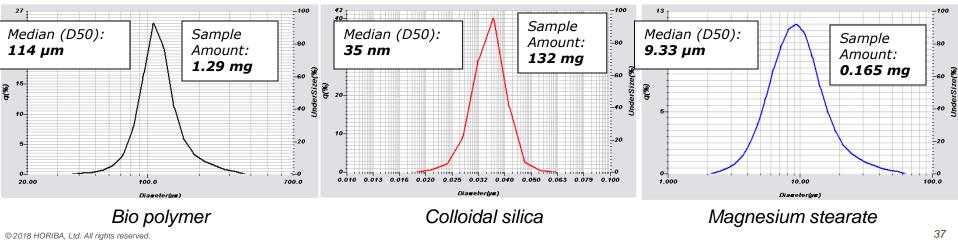
Lower volume samplers for precious materials or solvents



Sample Handlers	Dispersing Volume (mL)
Aqua/Solvo Flow	180 - 330
MiniFlow	35 - 50
Fraction Cell	15
Small Volume Fraction Cell	10



Note: Fraction cell has only magnetic stir bar, not for large or heavy particles



Explore the future

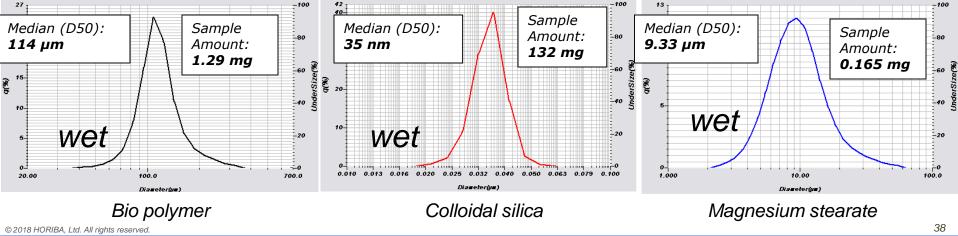


How much sample (dry)?

It depends on sample Larger, broad distributions require larger sample quantity

Can measure less than 5 mg (over a number of particle sizes).





Explore the future



Method Workflow

Determine particle refractive index (RI) Choose diluent (water, surfactants, hexane, etc.)

- Sampler selection: sample volume
- **Pump & stirrer settings**
- Concentration
- **Measurement duration**
- **Does the sample need ultrasound?**
 - **Document size-time plot**
 - Disperse sample, but don't break particles Check for reproducibility

© 2018 HORIBA, Ltd. All rights reserved.

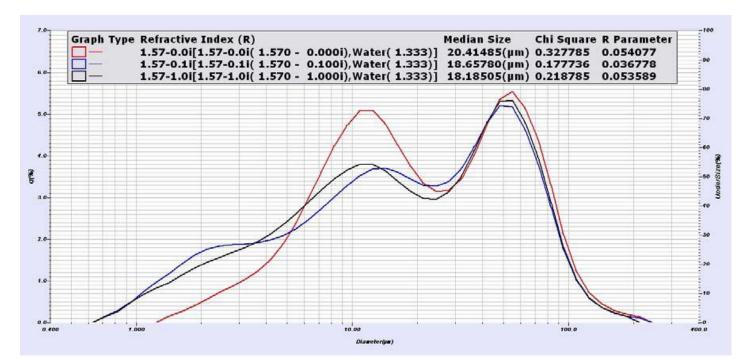


Determine Refractive Index

Real component via literature or web search, Becke line, etc.

Measure sample, vary imaginary component to see if/how results change

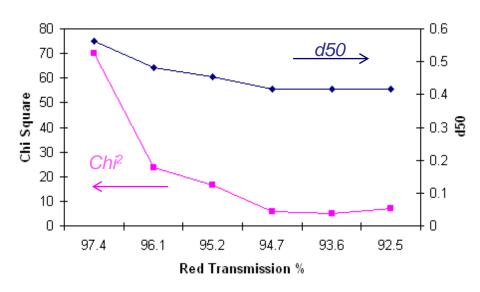
Recalculate using different imaginary components, choose value that minimizes R parameter error calculation

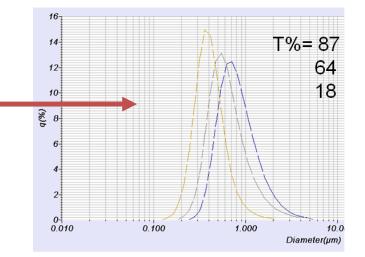


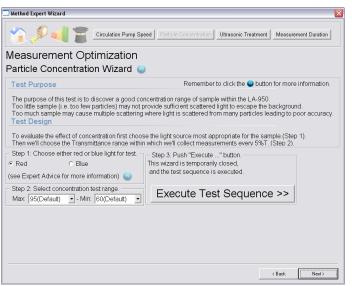


Concentration

High enough for good S/N ratio Low enough to avoid multiple scattering Typically 95 – 80 %T Measure at different T%, look at d50 result, Chi Square calculation









Ultrasonic Dispersion

Adding energy to break up agglomerates – disperse to primary particles, without breaking particles
Similar to changing air pressure on dry powder feeder
Typically set to 100% energy, vary time (sec) on
Investigate tails of distribution

High end to see if agglomerates removed

Small end to see if new, smaller particles appear (breakage)

Test reproducibility, consider robustness

Note:

Do not use on emulsions

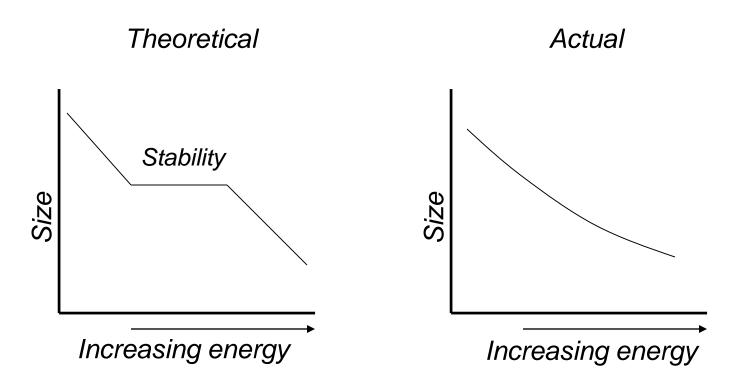
Can cause thermal mixing trouble w/solvents - wait

Use external probe if t> 2-5 minutes





Dispersion vs. Breakage

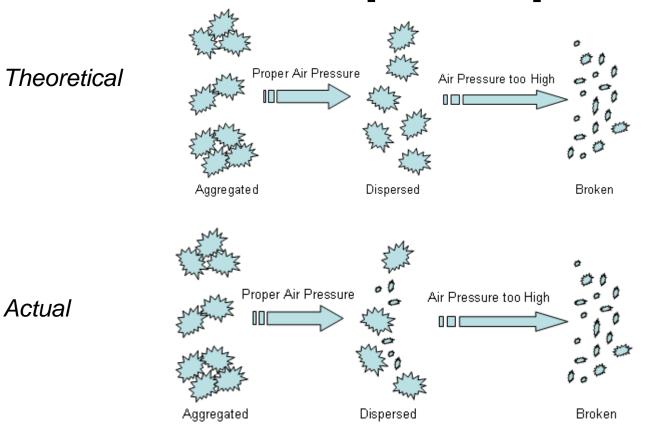


Higher air pressure or longer ultrasound duration



Dispersion vs. Breakage

Dispersion and milling can be parallel rather than sequential processes

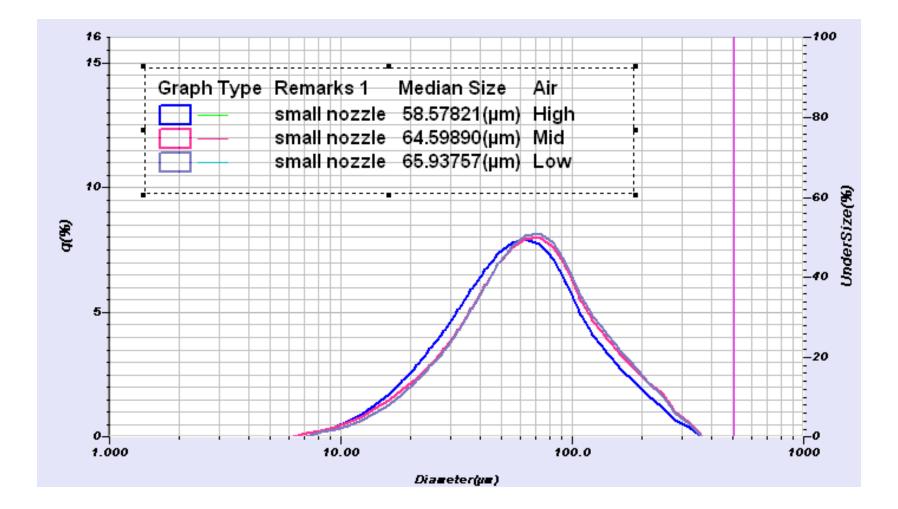


© 2018 HORIBA, Ltd. All rights reserved.

Explore the future



Effect of Air Pressure: MCC



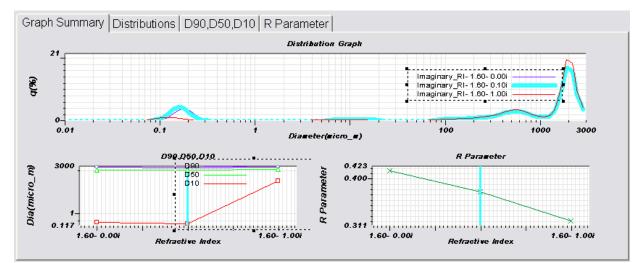
Explore the future



LA-960 Method Expert

Method Expert guides user to prepare the LA-960 for each test

Results displayed in multiple formats: PSD, D50, R-parameter



© 2018 HORIBA, Ltd. All rights reserved.

HORIBA



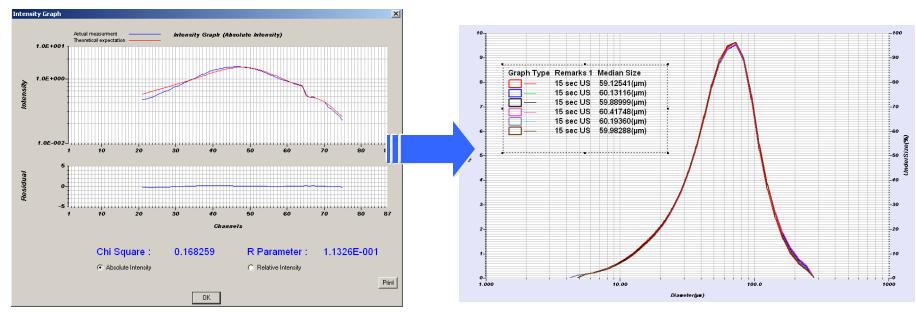
Measurement Workflow

Measurement

Click "Measure" button

Hardware measures scattered light distribution

Software then calculates size distribution

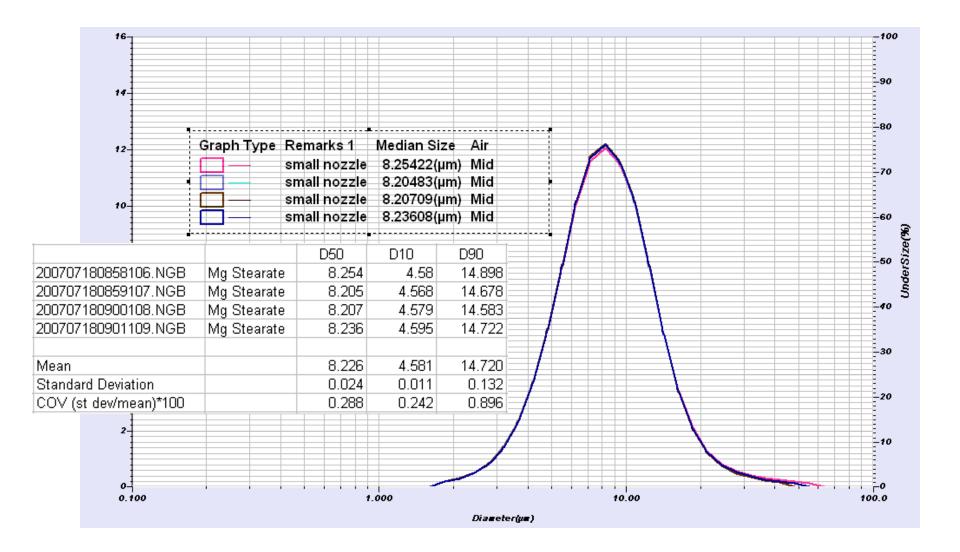


© 2018 HORIBA, Ltd. All rights reserved.

HORIBA



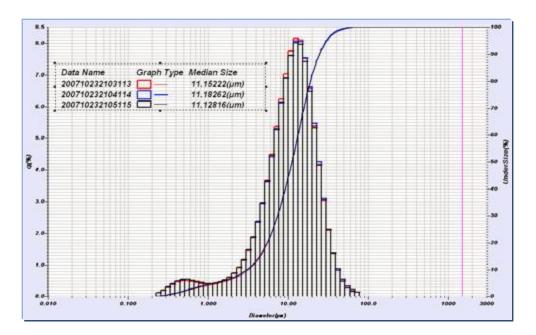
Reproducibility- Mg Stearate dry, 2 bar





Cement Dry

	D10	D50	d90
Portland Cement 1	3.255	11.152	24.586
Portland Cement 2	3.116	11.183	24.671
Portland Cement 3	3.112	11.128	24.92
Average	3.161	11.154	24.726
Std. Dev.	0.082	0.027	0.173
CV (%)	2.6	0.24	0.70



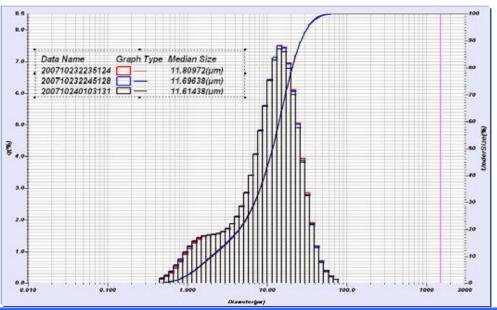




Cement Wet

Measure in isopropyl alcohol (IPA) (not water)

	D10	D50	d90
Portland Cement 1	2.122	11.81	27.047
Portland Cement 2	2.058	11.696	26.743
Portland Cement 3	1.999	11.614	27.001
Average	2.06	11.707	26.93
Std. Dev.	0.062	0.098	0.164
CV (%)	3.0	0.84	0.61





Instrument to instrument variation

20 instruments, 5 standards

Sample	CV D10	CV D50	CV D90		
PS202 (3-30µm)	2%	1%	2%		
PS213 (10-100µm)	2%	2%	2%		
PS225 (50-350µm)	1%	1%	1%		
PS235 (150-650µm)	1%	1%	2%		
PS240 (500-2000µm)	3%	2%	2%		
These are results from running polydisperse standards on 20 different instruments					



Instrument to instrument variation

Industrial Samples

	Dmean	D5	D10	D50	D90	D95
Average (nm)	155	1 <mark>1</mark> 2	119	152	193	208
Std. Dev. (nm)	0.8	0.8	0.7	1.0	1.1	0.7
CV (%)	0.5	0.7	0.6	0.6	0.6	0.3

e 8: Instrument to instrument variation across four LA-950 systems for Formulation 1.

	Dmean	D5	D10	D50	D90	D95
Average (nm)	193	136	147	187	247	264
Std. Dev (nm)	1.5	0.5	0.4	0.6	0.4	1.1
CV (%)	0.8	0.4	0.3	0.3	0.2	0.4

e 9: Instrument to instrument variation across four LA-950 systems for Formulation 2.

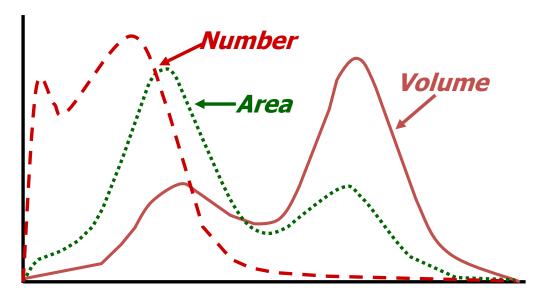
© 2018 HORIBA, Ltd. All rights reserved.



Diffraction Drawbacks

Volume basis by default Although excellent for mass balancing, cannot calculate number basis without significant error

No shape information



© 2018 HORIBA, Ltd. All rights reserved.



Benefits

Wide size range

Most advanced analyzer measures from 10 *nano* to 5 *milli*

Flexible sample handlers

Powders, suspensions, emulsions, pastes, creams Very fast

Allows for high throughput, 100's of samples/day

Easy to use

Many instruments are highly automated with selfguided software

Good design = Excellent precision

Reduces unnecessary investigation/downtime First principle measurement No calibration necessary

Massive global install base/history







Ask a question at labinfo@horiba.com

Keep reading the monthly <u>HORIBA Particle</u> e-mail newsletter!

Visit the <u>Download Center</u> to find the video and slides from this webinar.

www.horiba.com/us/particle

Jeff Bodycomb, Ph.D. P: 866-562-4698 E: jeff.bodycomb@horiba.com



© 2018 HORIBA, Ltd. All rights reserved.